N-CHANNEL ENHANCEMENT MODE MOSFET







### **Product Summary**

BV <sub>SSS</sub>	Rss(on) max	I <sub>S</sub> T <sub>A</sub> = +25°C
12V	$6.5 \text{m}\Omega$ @ $V_{GS} = 4.5 \text{V}$	16.6A
127	11.4m $\Omega$ @ V <sub>GS</sub> = 2.5V	12.1A

#### **Features**

- CSP with Footprint 2.70mm x 1.81mm
- Height = 0.21mm for Low Profile
- ESD Protection of Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

### **Description**

This new generation MOSFET is designed to minimize the on-state resistance ( $R_{SS(ON)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

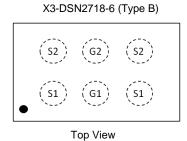
# Applications

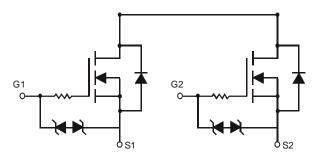
- Battery Management
- Load Switch
- Battery Protection

### **Mechanical Data**

- Case: X3-DSN2718-6 (Type B)
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu. Solderable per MIL-STD-202, Method 208 @4







**Equivalent Circuit** 

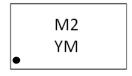
### **Ordering Information (Note 4)**

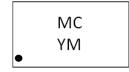
Part Number	Case	Packaging
DMN16M9UCA6-7	X3-DSN2718-6 (Type B)	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

### **Marking Information**





M2 / MC = Product Type Marking Code YM = Date Code Marking Y or  $\underline{Y}$  = Year (ex: E = 2017) M or  $\overline{M}$  = Month (ex: 9 = September)

#### Date Code Key

Year	201	5	2016		2017	20	18	2019		2020	2	2021
Code	С		D		E		F	G		Н		1
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



## **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Source-Source Voltage	Vsss	12	V		
Gate-Source Voltage	$V_{GSS}$	±12	V		
Continuous Source Current (Note 5) V <sub>GS</sub> = 4.5V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>S</sub>	16.6 13.2	Α
Continuous Source Current (Note 5) V <sub>GS</sub> = 2.5V	Is	12.1 9.7	Α		
Pulsed Source Current (Note 6)	I <sub>SM</sub>	80	А		

### **Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 7)	P <sub>D</sub>	1.0	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 7)	$R_{\theta JA}$	124.6	°C/W
Power Dissipation (Note 5)	P <sub>D</sub>	2.4	W
Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C (Note 5)	$R_{\theta JA}$	51.5	°C/W
Operating and Storage Temperature Range	$T_{J}, T_{STG}$	-55 to +150	°C

## **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

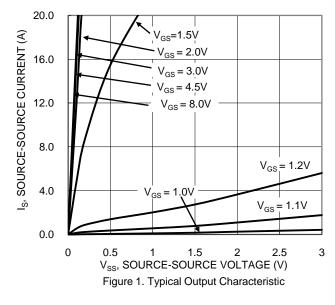
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition			
OFF CHARACTERISTICS (Note 8)									
Source-Source Breakdown Voltage	BV <sub>SSS</sub>	12	-	1	V	$V_{GS} = 0V$ , $I_S = 1mA$			
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>SSS</sub>	-	-	1	μΑ	$V_{SS} = 10V$ , $V_{GS} = 0V$			
Gate-Source Leakage	$I_{GSS}$	-	-	±10	μΑ	$V_{GS} = \pm 8V$ , $V_{SS} = 0V$			
ON CHARACTERISTICS (Note 8)									
Gate Threshold Voltage	V <sub>GS(TH)</sub>	0.5	-	1.3	V	V <sub>SS</sub> = 6V, I <sub>S</sub> = 1mA			
		2.3	5.0	6.5		$V_{GS} = 4.5V, I_{S} = 3A$			
		2.5	5.2	6.8		$V_{GS} = 4.0V, I_{S} = 3A$			
Static Source-Source On-Resistance	R <sub>SS(ON)</sub>	2.6	5.3	6.9	mΩ	$V_{GS} = 3.8V, I_S = 3A$			
	, ,	2.8	5.5	8.8		$V_{GS} = 3.1V, I_S = 3A$			
		3.0	6.0	11.4		$V_{GS} = 2.5V, I_S = 3A$			
Diode Forward Voltage	V <sub>SS</sub>	-	0.7	1.2	V	$V_{GS} = 0V$ , $I_S = 3A$			
DYNAMIC CHARACTERISTICS (Note 9)									
Input Capacitance	C <sub>iss</sub>	-	2360	-					
Output Capacitance	Coss	-	666	-	pF	$V_{SS} = 6V, V_{GS} = 0V,$ f = 1.0MHz			
Reverse Transfer Capacitance	C <sub>rss</sub>	-	325	-		I = I.OWINZ			
Total Gate Charge	Qq	-	35.2	-					
Gate-Source Charge	Q <sub>gs</sub>	-	7.0	-	nC	$V_{SS} = 6V, V_{GS} = 4.5V,$			
Gate-Drain Charge	Q <sub>gd</sub>	-	8.3	-	nc nc	I <sub>S</sub> = 18A			
Gate Charge at V <sub>TH</sub>	Q <sub>g(TH)</sub>	-	4.2	-					
Turn-On Delay Time	t <sub>D(ON)</sub>	-	615	-					
Turn-On Rise Time	t <sub>R</sub>	-	1447	-		$V_{SS} = 6V, V_{GS} = 4.5V,$			
Turn-Off Delay Time	t <sub>D(OFF)</sub>	-	2736	-	ns	$I_S = 3A$			
Turn-Off Fall Time	t <sub>F</sub>	-	3812	-					

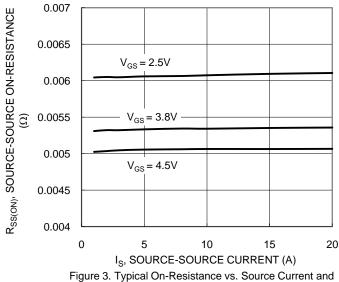
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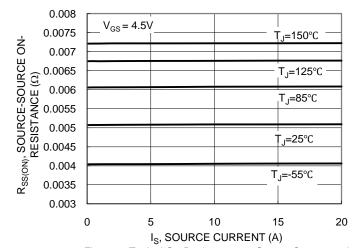
- Device mounted on FR-4 material with 1inch² (6.45cm²), 2oz. (0.071mm thick) Cu.
  Repetitive rating, pulse width limited by junction temperature.
  Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
  Short duration pulse test used to minimize self-heating effect.
  Guaranteed by design. Not subject to production testing.





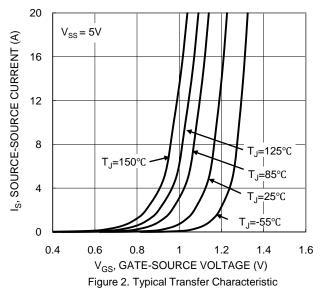


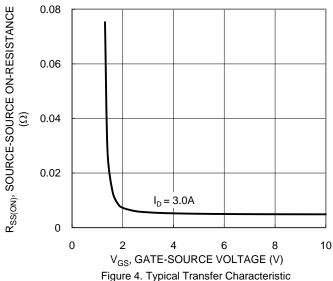




Gate Voltage

Figure 5. Typical On-Resistance vs. Source Current and Junction Temperature





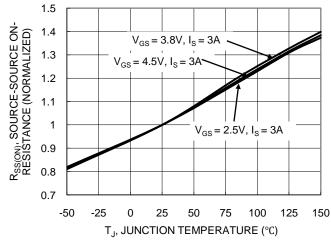


Figure 6. On-Resistance Variation with Junction Temperature





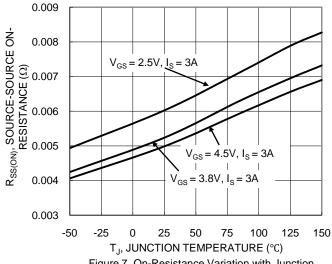
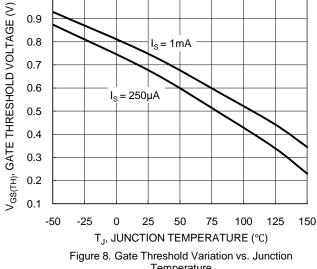


Figure 7. On-Resistance Variation with Junction Temperature



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Temperature

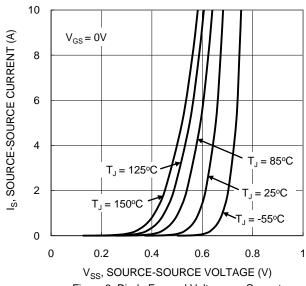
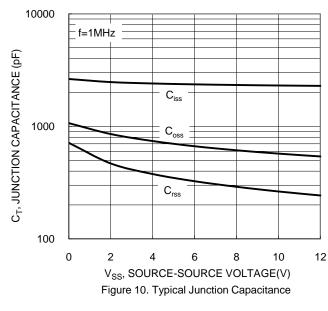
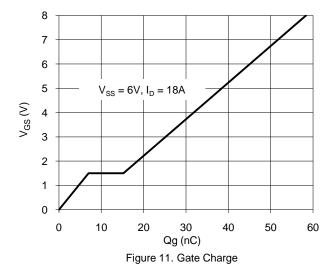
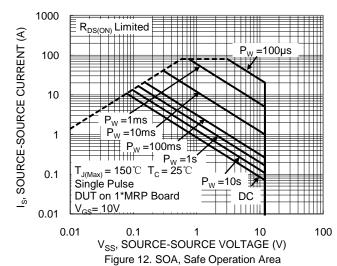


Figure 9. Diode Forward Voltage vs. Current









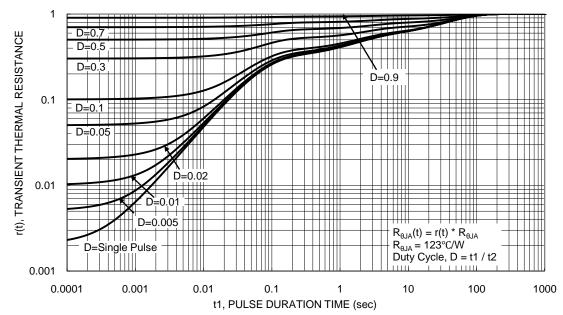


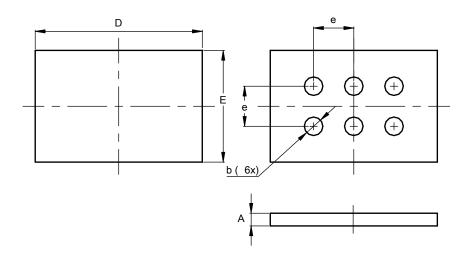
Figure 13. Transient Thermal Resistance



### **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### X3-DSN2718-6 (Type B)

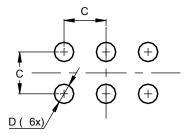


X3-DSN2718-6 (Type B)							
Dim	Min	Max	Тур				
Α	0.15	0.27	0.21				
b	<b>b</b> 0.27 0.33 0.30						
D	<b>D</b> 2.64 2.76 2.70						
Е	1.75	1.87	1.81				
е	0.62	0.68	0.65				
All Dimensions in mm							

### **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### X3-DSN2718-6 (Type B)



Dimensions	Value (in mm)		
С	0.65		
D	0.30		



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